PC401

■ Features

- 1. Mini-flat package
- 2. "High" output during light emission
- 3. Isolation voltage between input and output $(V_{iso}: 3750V_{rms})$
- 4. TTL and LSTTL compatible output
- 5. Recognized by UL(No.64380)

■ Applications

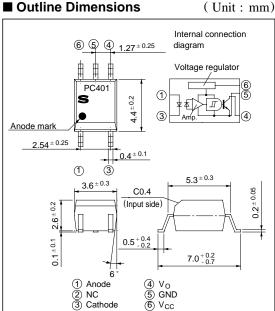
- 1. Hybrid substrate which requires high density mounting
- 2. Personal computers, office computers and peripheral equipment
- 3. Electronic musical instruments

■ Package Specifications

Model No.	Package specifications	Diameter of reel	Tape width	
PC401	Taping package (Net : 3 000pcs.)	370mm	12mm	
PC401T	Taping package (Net: 750pcs.)	178mm	12mm	
PC401Z	Sleeve package (Net : 100pcs.)	ı	-	

Compact, Surface Mount Type OPIC Photocoupler

■ Outline Dimensions

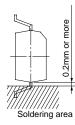


* "OPIC" (Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and signalprocessing circuit integrated onto a single chip.

■ Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$

	Parameter	Symbol	Rating	Unit	
Input	Forward current	I_F	50	mA	
	Reverse voltage	V _R	6	V	
	Power dissipation	P	70	mW	
	Supply voltage	V _{CC}	16	V	
Output	High level output voltage	V OH	16	V	
	Low level output current	I_{OL}	50	mA	
	Power dissipation	Po	130	mW	
То	Total power dissipation		150	mW	
*1 Iso	*1 Isolation voltage		3 750	V _{rms}	
Op	Operating temperature		- 25 to + 85	°C	
Storage temperature		T stg	- 40 to + 125	°C	
*2 Soldering temperature		T sol	260	°C	



^{*1} AC for 1 minute, 40 to 60% RH

^{*2} For 10 seconds

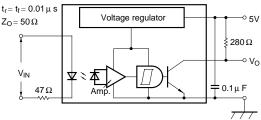
■ Electro-optical Characteristics

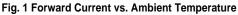
($Ta = 0 \text{ to} + 70^{\circ}\text{C}$ unless otherwise specified.)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input	Forward voltage		V _F	$I_F = 4mA$	-	1.1	1.4	V
				$I_F = 0.3 \text{mA}$	0.7	1.0	-	
	Reverse current		I_R	$Ta = 25^{\circ}C, V_R = 3V$		-	10	μΑ
	Terminal capacitance		Ct	$Ta = 25^{\circ}C, V = 0, f = 1kHz$	-	30	250	pF
Output	Operating supply voltage		V _{CC}		3	-	15	V
	Low level output voltage		V _{OL}	$I_F = 0, V_{CC} = 5V, I_{OL} = 16mA$	-	0.2	0.4	V
	High level output current		Іон	$I_F = 4mA, V_{CC} = V_O = 15V$	-	-	100	μΑ
	Low level supply current		I_{CCL}	$I_F = 0, V_{CC} = 5V$	-	2.5	5.0	mA
	High level supply current		I _{CCH}	$I_F = 4mA, V_{CC} = 5V$	-	2.7	5.5	mA
Transfer charac- teristics	*3 "H→L" threshold		I _{FHL}	$Ta = 25^{\circ}C$, $V_{CC} = 5V$, $R_L = 280\Omega$	0.4	0.8	-	mA
	input current			$V_{\rm CC} = 5$ V, $R_{\rm L} = 280\Omega$	0.3	-	-	
	*4 "L→H" threshold		I _{FLH}	$Ta = 25^{\circ}C, V_{CC} = 5V, R_{L} = 280\Omega$	-	1.1	2.0	mA
	input current			$V_{CC} = 5V, R_L = 280\Omega$	-	-	4.0	
	*5Hysteresis		I FHL /I FLH	$V_{CC} = 5V, R_L = 280\Omega$	0.5	0.7	0.9	
	Isolation resistance		R _{ISO}	Ta= 25°C,DC500V,40 to 60% RH	5 x 10 ¹⁰	10^{11}	-	Ω
	se .	'H→L" propagation delay time	t PHL		-	2	6	
	nod	'L→H" propagation delay time	t PLH	$Ta = 25^{\circ}C, V_{CC} = 5V$	-	1	3	
	*6 Response time	Fall time	t_{f}	$R_L = 280\Omega$, $I_F = 4mA$	-	0.05	0.5	μs
	*6 j	Rise time	$t_{\rm r}$		-	0.1	0.5	

^{*3} I $_{\text{FHL}}$ represents forward current when output gose from high to low.

Test Circuit for Response Time





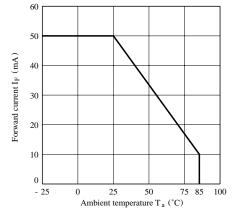
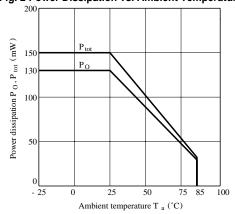


Fig. 2 Power Dissipation vs. Ambient Temperature



^{*4} I FLH represents forward current when output goes from low to high.

^{*5} Hysteresis stands for I_{FHL} /I _{FLH} .

^{*6} Test circuit for response time is shown below.

Fig. 3 Forward Current vs. Forward Voltage

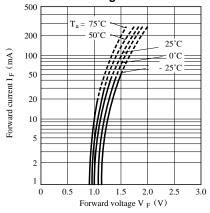


Fig. 5 Relative Threshold Input Current vs. Ambient Temperature

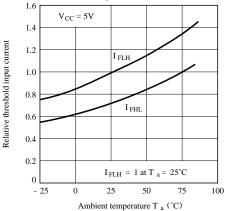


Fig. 7 Low Level Output Voltage vs.
Ambient Temperature

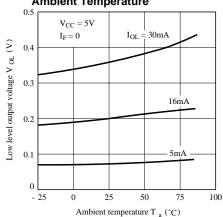


Fig. 4 Relative Threshold Input Current vs. Supply Voltage

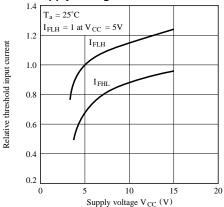


Fig. 6 Low Level Output Voltage vs. Low Level Output Current

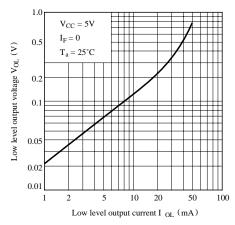


Fig. 8 High Level Output Current vs. Forward Current

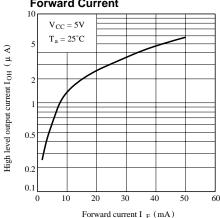


Fig. 9 High Level Output Current vs.
Ambient Temperature

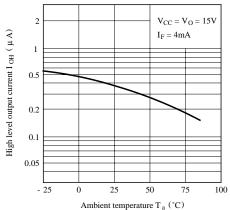


Fig.11 Propagation Delay Time vs. Forward Current

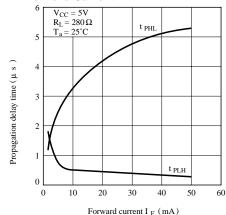


Fig.10 Supply Current vs. Supply Voltage

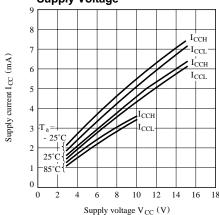
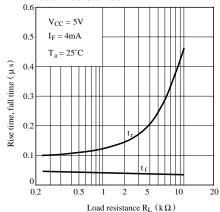


Fig.12 Rise Time, Fall Time vs. Load Resistance



■ Preautions for Use

- (1) It is recommended that a by-pass capacitor of more than 0.01μ F is added between V_{cc} and GND near the device in order to stabilize power supply line.
- (2) Handle this product the same as with other integrated circuits against static electricity.
- (3) As for other general cautions, refer to the chapter "Precautions for Use"

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